

Search Notes

Application/Control No.

10/611,340

Examiner

Long K. Tran

Applicant(s)/Patent under
Reexamination

HATHAWAY ET AL.

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
257	678,728	4/26/2005	LKT
257	531,724	4/26/2005	LKT
257	531	4/26/2005	LKT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	678	4/26/2005	LKT
257	531	4/26/2005	LKT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST searched	4/26/2005	LKT